

High-Brilliance Micro-Focus X-ray Sources for Diffractometry

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Göbel mentors
development
Multilayer X-ray optics
10 years
of innovations
made in Germany
Incoatec
Microfocus Sources
Montel Optics
High Brilliance
µS

Incoatec Microfocus Source μ S and 2D Montel Optics

The μ S is the perfect upgrade for equipment in X-ray diffractometry. It combines the advantages of a sealed-tube system with the superior data quality of conventional rotating anode systems. The μ S is also included in the new equipment of Bruker AXS: for SAXS in the NANOSTAR and for SC-XRD in the D8 QUEST and VENTURE solutions for crystallography. The μ S consists of a microfocus source and a specially designed multilayer optics named Quazar.

The source

- high brilliance & best spectral purity
- Cu, Mo, Cr and Ag radiation available
- air cooled
- < 40 μ m spot size at the anode
- convenience of sealed-tube
- high voltage generator

3-Year warranty

Quazar Optics

- 2-dim beam shaping
- collimating, focussing or collimating + focussing (hybrid)
- patented housing for high stability and easy alignment
- motorized alignment (optional)

Optics	Divergence (mrad)	Beam size (mm)	Flux density (ph/s mm ²)
Cu-MX	7.6	0.11	> 18 x 10 ⁹
Mo	4.9	0.11	> 1.9 x 10 ⁹
Ag	4.9	0.095	> 0.9 x 10 ⁹

Different types of Quazar Optics for the μ S^{High Brilliance}



Optics in high-stability housing

NEW μ S^{High Brilliance}

- up to 60 % more flux due to improved optical design
- for Cu, Mo & Ag
- component recognition
- improved safety features
- compliant with Machinery Directive 2006/42/EC



μ S integrated in a new Bruker D8 DISCOVER (left) and component recognition (right)

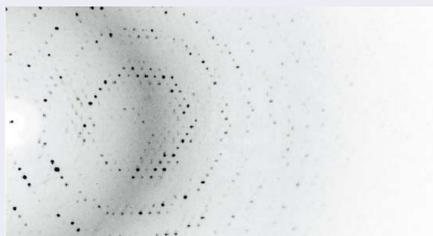


New μ S^{High Brilliance} System with 19" wide stand-alone generator

μ S for Cu Radiation: SAD Phasing on Glucose Isomerase (Quazar Optics)

Sample: glucose isomerase
 $a = 93.88 \text{ \AA}$, $b = 99.68 \text{ \AA}$, $c = 102.90 \text{ \AA}$; I222; $T = 100 \text{ K}$;
388 amino acids / ASU

crystal size	0.24x0.24x0.15 mm ³	<redundancy>	14.4 (4.5)
exposure time	40 s / 0.5°	<completeness>	98.0 % (89.8 %)
total time	~ 43 h	R_{int}	0.0652 (0.4191)
resolution	35-1.50 \AA (1.60-1.50 \AA)	$R_{p,im}$	0.0149 (0.1959)
< I/ σ >	21.8 (3.5)	$R1(I > 2\sigma(I); \text{all})$	0.1587; 0.2047
anom. signal limit	2.7 \AA (Ca^{2+} , 9 S)		

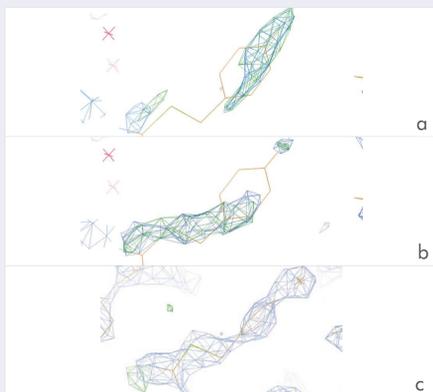


Data statistics and a typical diffraction pattern of glucose isomerase. Ca^{2+} site has been found in the initial phasing with SHELXD; measured with a Bruker Smart6000 diffractometer equipped with the μ S (Quazar optics).

Fragment Screening (Quazar MX Optics)

Sample: Twinned crystal of an enzyme in complex with a small molecule fragment

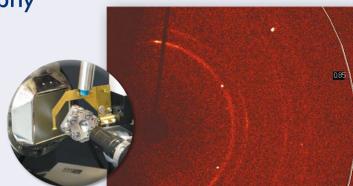
crystal size	0.45 x 0.07 x 0.04 mm ³	<completeness>	95.9 % (85.8 %)
exposure time	15 s / 0.5°	R_{int}	0.0679 (0.1052)
total time	3.5 h	R_c	0.0642 (0.1936)
resolution	41-2.59 \AA (2.69-2.59 \AA)	R_1	0.1331
< I/ σ >	18.0 (5.7)		



Electron density map (Fo-Fc, 1.5 σ in blue, 2Fo-mFc 3 σ in green) of the ligand after rigid body refinement with 60 % completeness (a, after 1 h), 80 % completeness (b, after 1.3 h) and 96 % data completeness (c, after 3.5 h and SHELXL refinement). (data from A. Heine, Philipps University Marburg, Germany)

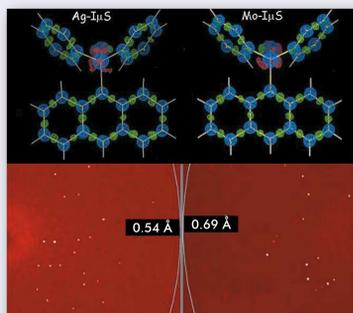
μ S for Ag Radiation: Best for High-Pressure Crystallography

The small beam cross-section of the μ S for Mo and Ag radiation reveals what an interesting alternative they are to sealed tube sources for diffraction studies on single crystals and powders using diamond anvil cells for high-pressure crystallography. The focused beam reduces part of the background caused by scattering at the gasket, thus improving the signal-to-noise ratio.



Highly Absorbing Crystals

In Ag radiation the μ S delivers a peak flux density of about 0.9 x 10⁹ photons/(s mm²) in a 90 μ m beam (FWHM), which is ideal for small crystals, especially of absorbing materials. The advantage of such short wavelengths is the reduced absorption and extinction, as well as the „compressed“ reciprocal space thus gaining access to a larger range of d -spacings at a fixed 2θ setting. The figure shows the comparison of two single crystal diffraction experiments with the Ag- μ S and the Mo- μ S on an organic sample.

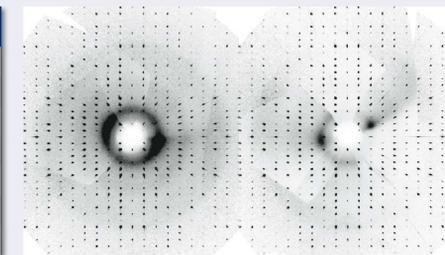


Residual density and the resolution limit (at $2\theta = 31^\circ$; $DX = 51 \text{ mm}$) for $\text{C}_{20}\text{H}_{10}\text{PS}$: Ag- μ S (200 s², left), Mo- μ S (77 s², right) (data from F.P. Fabbiani, University Göttingen, Germany)

μ S for Mo Radiation: Perfect for Small Crystals; Good for Big Ones

Source	μ S	Sealed Tube	μ S	Sealed Tube
Size [mm ³]	0.10 x 0.05 x 0.05		0.30 x 0.25 x 0.15	
Power [kW]	0.03	2.0	0.03	2.0
Exposure time [s/°]	100	300	33	50
< I >	139	19	4763	1286
< I/ σ >	15.3; 3.5*	10.7; 2.1*	37.6; 21.1*	30.4; 13.6*
R_{int}	0.039	0.062	0.021	0.023
$R1(\text{all}); wR2(\text{all})$	0.039; 0.092	0.056; 0.105	0.030; 0.082	0.031; 0.082

Details of four sets of data collected on $\text{C}_2\text{H}_2\text{N}_2\text{O}_8$ (# normalized to 1°/min; * values for highest resolution shell 0.85 - 0.75 \AA) (data from T. Schulz, D. Stalke, University Göttingen, Germany)

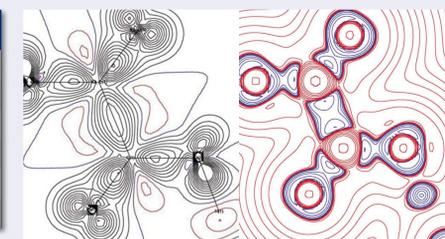


Calculated precession plots of the $hk0$ layer for an organic sample: Mo-Sealed Tube (67 s², left), Mo- μ S (16 s², right)

Challenging Rotating Anodes

Source	μ S	RAG	μ S	RAG
Size [mm ³]	0.02 x 0.04 x 0.04		d=0.18 (sphere)	
Power [kW]	0.03	4.0	0.02	4.0
Exposure time [s/°]	150	150	20	20
< I >	17.1	5.9	344.1	537.9
< σ >	1.6	1.1	5.1	6.8
$R1(\text{all}); wR2(\text{all})$	0.084; 0.240	0.090; 0.241	0.036; 0.082	0.041; 0.082

Details for sets of data recorded on a smaller quartz crystal SiO_2 and a larger crystal of ammonium-bitartrate $\text{C}_4\text{H}_8\text{O}_6\text{N}_2$. (data from C.W. Lehmann, MPI Mülheim, Germany)



Charge density study on oxalic acid. Multipole refinement: No. of unique 3784; Refinement incl. 2450; R(F) 0.036; N(ref)/N(var) 23.1; H-Atoms constrained.

μ S for Small Angle X-ray Scattering

The μ S was integrated in the Bruker Nanostar, an equipment for SAXS and simultaneous WAXS measurements with a 3-pinhole geometry. The beam was collimated using a Quazar optics with a low divergence of 1mrad or smaller.

in-situ GISAXS with Liquid Samples

For rapid GISAXS measurements of liquid samples our μ S was combined with a Dectris Pilatus detector. The set-up can be changed from liquids to capillary samples within <30 min, alignment included (picture and data courtesy of P. Šiffalovič, Slovak Academy of Science). The measurement shows an ordering of the particles. It was possible to study the evolution of the ordering with increasing surface pressure in-situ.

GISAXS

With the μ S GISAXS measurements of high data quality can also be carried out in the lab. The figure shows the results of an ion-beam sputtered Mo/Si multilayer. The total reflection and three Bragg sheets are clearly visible.

Sample: Langmuir film with silver nanoparticles

- the surface was pressed with 26mN/m
- 180 s measurement time, aperture 350 μ m

